Notice of References Cited Application/Control No. 10/064,777 Examiner EDWYN LABAZE Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*	_	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,235,448	08-1993	Suzuki et al.	349/43
	В	US-5,629,783	05-1997	Kanbara et al.	349/70
	С	US-5,745,194	04-1998	Nakashima et al.	349/38
	D	US-5,886,365	03-1999	Kouchi et al.	257/59
	E	US-5,978,059	11-1999	Ohta et al.	349/141
	F	US-6,028,650	02-2000	Kuroha et al.	349/38
	G	US-6,046,790	04-2000	Hara et al.	349/172
	I	US-6,115,018	09-2000	Okumura et al.	345/95
	-	US-2002/0080317	06-2002	Yeo et al.	349/149
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	7	04225329	08-1992	JP	Sasaki, Makoto	349/51
	0					
	Ρ					
	O					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U					
	٧					
	W					
	Х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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